



## P-Channel 20 V (D-S) MOSFET with Schottky Diode

MOSFET PRODUCT SUMMARY						
V <sub>DS</sub> (V)	$R_{DS(on)}(\Omega)$	I <sub>D</sub> (A)	Q <sub>g</sub> (Typ.)			
	0.105 at V <sub>GS</sub> = - 4.5 V	- 4 <sup>a</sup>				
- 20	0.143 at V <sub>GS</sub> = - 2.5 V	- 3.8	4.7 nC			
	0.188 at V <sub>GS</sub> = - 1.8 V	- 3				

SCHOTTKY PRODUCT SUMMARY					
V <sub>KA</sub> (V)	V <sub>f</sub> (V) Diode Forward Voltage	I <sub>F</sub> (A)			
20	0.46 at 0.5 A	1			

#### **FEATURES**

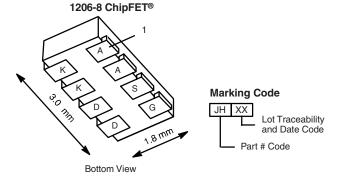
- Halogen-free According to IEC 61249-2-21 Definition
- LITTLE FOOT® Plus Schottky Power MOSFET
- Compliant to RoHS Directive 2002/95/EC

## Pb-free

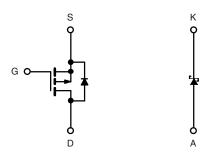


#### **APPLICATIONS**

- Charging Switch for Portable Devices
  - With Integrated Low V<sub>f</sub> Trench Schottky Diode



Ordering Information: Si5853DDC-T1-E3 (Lead (Pb)-free) Si5853DDC-T1-GE3 (Lead (Pb)-free and Halogen-free)



P-Channel MOSFET

Parameter	Symbol	Limit	Unit		
Drain-Source Voltage (MOSFET)	V <sub>DS</sub>	- 20			
Reverse Voltage (Schottky)		20	V		
Gate-Source Voltage (MOSFET)		± 8			
	T <sub>C</sub> = 25 °C		- 4 <sup>a</sup>		
Continuous Drain Current (T = 150 °C) (MOSEET)	T <sub>C</sub> = 70 °C		- 3.5		
Continuous Drain Current (T <sub>J</sub> = 150 °C) (MOSFET)	$V_{DS}$ $V_{KA}$ $V_{GS}$ $T_{C} = 25  ^{\circ}C$	- 2.9 <sup>b, c</sup>			
		$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	- 2.3 <sup>b, c</sup>		
Pulsed Drain Current (MOSFET)	1	I <sub>DM</sub>	- 10	Α	
(MOOFFT Discharge Landing)	T <sub>C</sub> = 25 °C		- 2.6		
Continuous Source Current (MOSFET Diode Conduction)		'S	- 1.1 <sup>b, c</sup>		
Average Forward Current (Schottky)	1	I <sub>F</sub>	1		
Pulsed Forward Current (Schottky)			3		
	T <sub>C</sub> = 25 °C		3.1		
Manipus Barra Birainatian (MOOFFT)	T <sub>C</sub> = 70 °C	$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	2		
Maximum Power Dissipation (MOSFET)	T <sub>A</sub> = 25 °C		1.3 <sup>b, c</sup>		
	T <sub>A</sub> = 70 °C		- 20 20 ± 8 - 4 <sup>a</sup> - 3.5 - 2.9 <sup>b, c</sup> - 2.3 <sup>b, c</sup> - 10 - 2.6 - 1.1 <sup>b, c</sup> 1 3 3.1 2 1.3 <sup>b, c</sup> 0.8 <sup>b, c</sup> 2.5 1.6 1.2 0.76 - 55 to 150	14/	
		PD	2.5	w	
Manifestory Develop District (Only 1997)			1.6		
Maximum Power Dissipation (Schottky)	T <sub>A</sub> = 25 °C		1.2		
T <sub>A</sub> = 70 °C			0.76		
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150	°C	
Soldering Recommendation (Peak Temperature) <sup>d, e</sup>			260		

## Si5853DDC

## Vishay Siliconix



THERMAL RESISTANCE RATINGS							
Parameter	Symbol	Typical	Maximum	Unit			
Maximum Junction-to-Ambient (MOSFET) <sup>b, c, f</sup>	$R_{thJA}$	77	95				
Maximum Junction-to-Foot (Drain) (MOSFET)	$R_{thJF}$	33	40	°C/W			
Maximum Junction-to-Ambient (Schottky) <sup>b, c, g</sup>	$R_{thJA}$	85	105	O/VV			
Maximum Junction-to-Foot (Drain) (Schottky)	R <sub>thJF</sub>	40	50				

#### Notes:

- a. Package limited.
- b. Surface mounted on FR4 board.
- c. t ≤ 5 s
- d. See Solder Profile (<a href="www.vishay.com/doc?73257">www.vishay.com/doc?73257</a>). The ChipFET is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- e. Rework conditions: manual soldering with a soldering iron is not recommended for leadless components.
- f .Maximum under steady state conditions for MOSFETs is 130 °C/W.
- g. Maximum under steady state conditions for Schottky is 125 °C/W.

Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Static	-				I.	l .
Drain-Source Breakdown Voltage	$V_{DS}$	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$	- 20			V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS/TJ}$	J 250 A		- 13		
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)/TJ}$	I <sub>D</sub> = - 250 μA		2.4		mV/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	- 0.4		- 1	V
Gate-Body Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 8 \text{ V}$			± 100	nA
Zara Cata Valtaria Dirain Comment		$V_{DS} = -20 \text{ V}, V_{GS} = 0 \text{ V}$			- 1	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{DS} = -20 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 85 ^{\circ}\text{C}$			- 10	μΑ
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \le -5 \text{ V}, V_{GS} = -4.5 \text{ V}$	- 10			Α
		$V_{GS} = -4.5 \text{ V}, I_D = -2.9 \text{ A}$		0.085	0.105	
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	$V_{GS} = -2.5 \text{ V}, I_D = -2.5 \text{ A}$		0.117	0.143	Ω
	V <sub>GS</sub> = - 1.8 V, I <sub>D</sub> = - 1.5 A	V <sub>GS</sub> = - 1.8 V, I <sub>D</sub> = - 1.5 A		0.155	0.188	
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = - 10 V, I <sub>D</sub> = - 2.9 A		7		S
Dynamic <sup>b</sup>	<u>'</u>		·	'	I.	
Input Capacitance	C <sub>iss</sub>			320		pF
Output Capacitance	C <sub>oss</sub>	$V_{DS} = -10 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		60		
Reverse Transfer Capacitance	C <sub>rss</sub>			47		
Total Cata Chavas	0	V <sub>DS</sub> = - 10 V, V <sub>GS</sub> = - 8 V, I <sub>D</sub> = - 2.9 A		7.9	12	
Total Gate Charge	Q <sub>g</sub>			4.7	7.1	
Gate-Source Charge	$Q_{gs}$	$V_{DS} = -10 \text{ V}, V_{GS} = -4.5 \text{ V}, I_{D} = -2.9 \text{ A}$		0.65		nC
Gate-Drain Charge	Q <sub>gd</sub>			1.35		
Gate Resistance	$R_g$	f = 1 MHz		6.5		Ω
Turn-On Delay Time	t <sub>d(on)</sub>			15	25	
Rise Time	t <sub>r</sub>	$V_{DD}$ = - 10 V, $R_L$ = 4.4 $\Omega$		17	30	
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong -2.3 \text{ A}, V_{GEN} = -4.5 \text{ V}, R_g = 1 \Omega$		21	30	
Fall Time	t <sub>f</sub>			10	15	1
Turn-On Delay Time	t <sub>d(on)</sub>			5	10	ns
Rise Time	t <sub>r</sub>	$V_{DD}$ = - 10 V, $R_L$ = 4.4 $\Omega$		10	15	
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong$ - 2.3 A, $V_{GEN}$ = - 8 V, $R_g$ = 1 $\Omega$		20	30	
Fall Time	t <sub>f</sub>			10	15	1





<b>SPECIFICATIONS</b> $T_J = 25$ °C, unless otherwise noted								
Parameter	rameter Symbol Test Conditions Min.							
Drain-Source Body Diode Characteristics								
Continuous Source-Drain Diode Current	Is	T <sub>C</sub> = 25 °C			- 2.6	Α		
Pulse Diode Forward Current	I <sub>SM</sub>				- 10	A		
Body Diode Voltage	$V_{SD}$	I <sub>S</sub> = - 2.3 A, V <sub>GS</sub> = 0 V		- 0.85	- 1.2	V		
Body Diode Reverse Recovery Time	t <sub>rr</sub>			15	30	ns		
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	   I <sub>E</sub> = - 2.3 A dl/dt = 100 A/μs T <sub>I</sub> = 25 °C		9	20	nC		
Reverse Recovery Fall Time	t <sub>a</sub>	1 = -2.5 A α/αι = 100 A/μ3 1		10		ns		
Reverse Recovery Rise Time	t <sub>b</sub>			5		115		

#### Notes:

a. Pulse test; pulse width  $\leq 300~\mu s,$  duty cycle  $\leq 2~\%.$ 

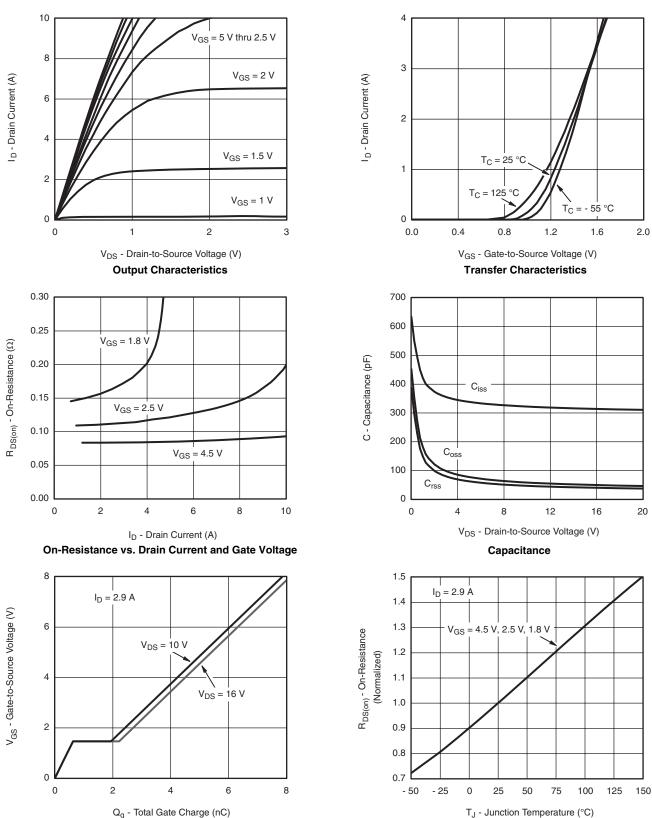
b. Guaranteed by design, not subject to production testing.

Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
		I <sub>F</sub> = 0.5 A		0.381	0.46	
Forward Voltage Drop	$V_{F}$	I <sub>F</sub> = 1 A		0.468	0.560	V
		I <sub>F</sub> = 1 A, T <sub>J</sub> = 125 °C		0.44	0.53	
		V <sub>r</sub> = 5 V		0.0081	0.080	
		$V_r = 5 \text{ V}, T_J = 85 \text{ °C}$ $V_r = 5 \text{ V}, T_J = 125 \text{ °C}$		0.4	4	]
Maximum Dayaraa Laakaaa Current				2.8	28	
Maximum Reverse Leakage Current	Irm	V <sub>r</sub> = 20 V		0.0093	0.09	mA
		V <sub>r</sub> = 20 V, T <sub>J</sub> = 85 °C		0.45	4.5	
		V <sub>r</sub> = 20 V, T <sub>J</sub> = 125 °C		3.2	32	
Junction Capacitance	C <sub>T</sub>	V <sub>r</sub> = 10 V		30		pF

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

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#### MOSFET TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



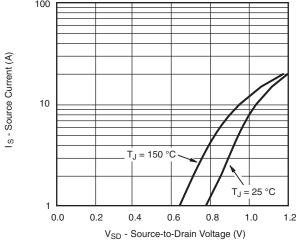
**Gate Charge** 

On-Resistance vs. Junction Temperature

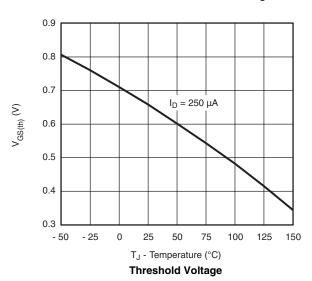




#### MOSFET TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

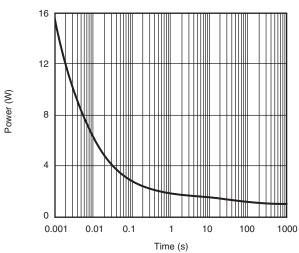


#### Source-Drain Diode Forward Voltage

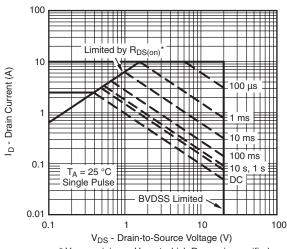


 $C_{D} = 2.9 \text{ A}$   $C_{D$ 

On-Resistance vs. Gate-to-Source Voltage



Single Pulse Power, Junction-to-Ambient

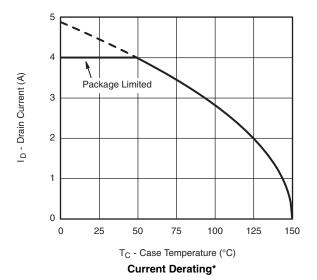


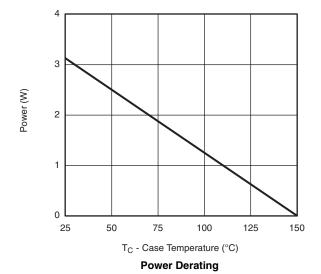
\*  $V_{GS}$  > minimum  $V_{GS}$  at which  $R_{DS(on)}$  is specified

Safe Operating Area, Junction-to-Ambient

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#### MOSFET TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

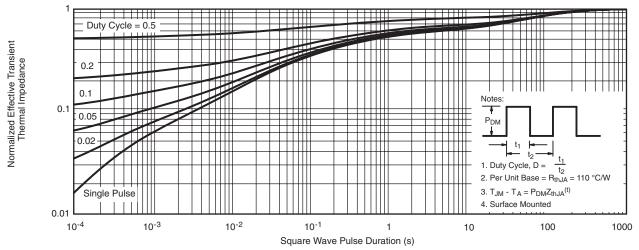




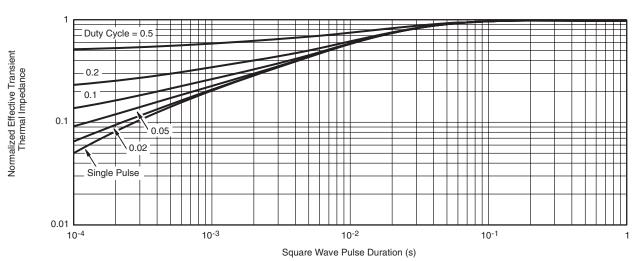
<sup>\*</sup> The power dissipation  $P_D$  is based on  $T_{J(max)} = 150$  °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



#### MOSFET TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



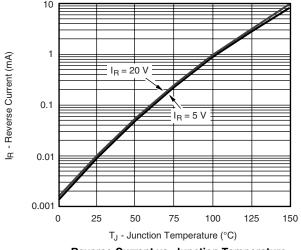
Normalized Thermal Transient Impedance, Junction-to-Ambient

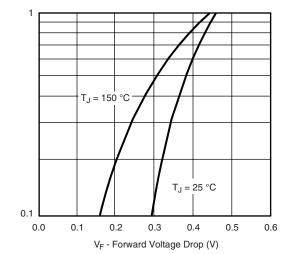


Normalized Thermal Transient Impedance, Junction-to-Foot



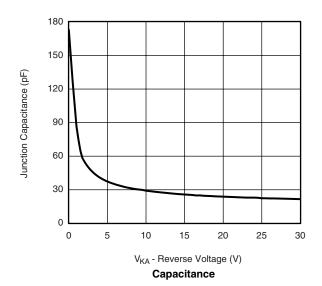
#### SCHOTTKY TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted





**Reverse Current vs. Junction Temperature** 

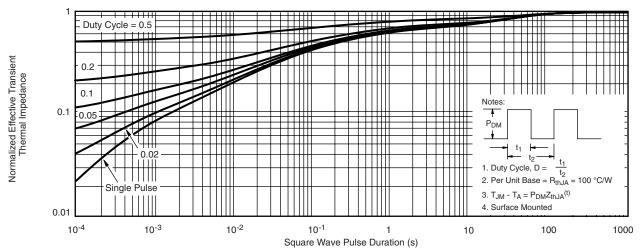
**Forward Voltage Drop** 



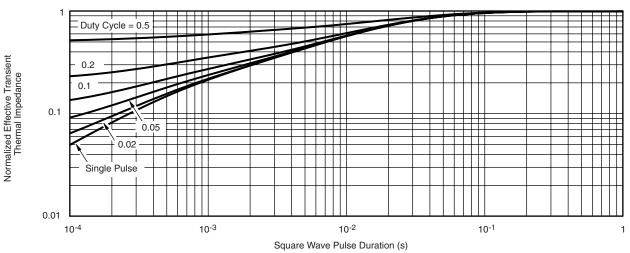
IF - Forward Current (A)



#### SCHOTTKY TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Normalized Thermal Transient Impedance, Junction-to-Ambient

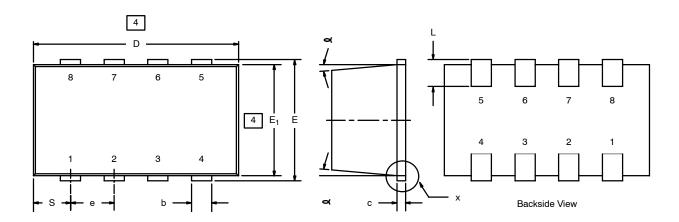


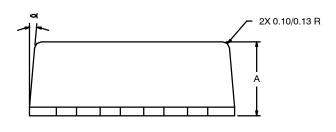
Normalized Thermal Transient Impedance, Junction-to-Foot

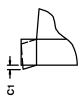
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#### 1206-8 ChipFET®







**DETAIL X** 

#### NOTES:

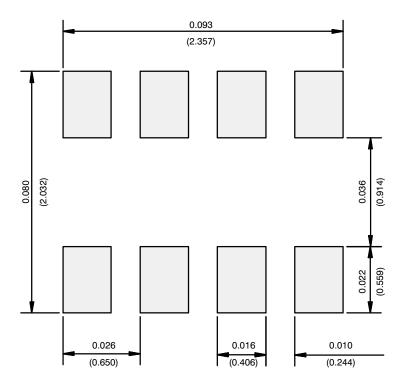
- 1. All dimensions are in millimeaters.
- 2. Mold gate burrs shall not exceed 0.13 mm per side.
- Leadframe to molded body offset is horizontal and vertical shall not exceed
- 4. Dimensions exclusive of mold gate burrs.
- 5. No mold flash allowed on the top and bottom lead surface.

	MIL	LIMET	ERS		S		
Dim	Min	Nom	Max	Min	Nom	Max	
Α	1.00	-	1.10	0.039		0.043	
b	0.25	0.30	0.35	0.010	0.012	0.014	
С	0.1	0.15	0.20	0.004	0.006	0.008	
c1	0	-	0.038	0	-	0.0015	
D	2.95	3.05	3.10	0.116	0.120	0.122	
E	1.825	1.90	1.975	0.072	0.075	0.078	
E <sub>1</sub>	1.55	1.65	1.70	0.061	0.065	0.067	
е		0.65 BSC			0.0256 BS	0	
L	0.28	-	0.42	0.011	-	0.017	
S	0.55 BSC 0.022 BSC						
9	5°Nom			5°Nom			
ECN: C-03528—Rev. F, 19-Jan-04 DWG: 5547							

www.vishay.com 15-Jan-04



## RECOMMENDED MINIMUM PADS FOR 1206-8 ChipFET®



Recommended Minimum Pads Dimensions in Inches/(mm)

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Vishay Intertechnology, Inc. hereby certifies that all its products that are identified as RoHS-Compliant fulfill the definitions and restrictions defined under Directive 2011/65/EU of The European Parliament and of the Council of June 8, 2011 on the restriction of the use of certain hazardous substances in electrical and electronic equipment (EEE) - recast, unless otherwise specified as non-compliant.

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